

<b>Notice of References Cited</b>	Application/Control No. 10/560,060	Applicant(s)/Patent Under Reexamination FAN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0191970	10-2003	Devine et al.	713/201
*	B	US-6,470,386	10-2002	Combar et al.	709/224
*	C	US-2001/0052013	12-2001	MUNGUIA et al.	709/225
*	D	US-5,905,715	05-1999	Azarmi et al.	370/244
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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